Chip Scale Review

2019 Editorial Calendar

(Editorial close date: 12/1/2018	January • February	Industry Events * indicates show distribution	
New test methodologies for 5G		 APEX Expo San Diego, CA (Jan 26-31) 3D & Systems Summit Dresden, Germany (Jan 28-30) 	
RF/OTA			
Thermal debonding and warpage in FOWLP		SMTA Pan Pac Microelectronics Symposium Kauai, Hawaii (Feb 11-14) FLEX / MEMS & Sensors Technical Congress Monterey, CA (Feb 18-21)	
W2W/D2W & other bonding advances for 3D ICs			
Temporary bonding & the challenges of cleaning post debond			
Discontinuities drive data integration			
IC packaging for Moore's Law			
Heterogeneous integration			
Thin wafer handling			

Ad Space Close Jan 18 - Ad Materials Close Jan 25

(Editorial close date: 2/28/19)	March • April	Industry Events * indicates show distribution
High density advanced packaging		TestConX Mesa, AZ (March 3-6)
3D IC metrology		IMAPS Device Packaging Fountain Hills, AZ (March 4-7)
3D system packaging		SEMI-THERM San Jose, CA (March 18-22)
Electroplating models for 3D TSVs		SEMICON China Shanghai, China (March 20-22)
Failure relief in WLP & PLP polymer layers		ISS Europe Milan, Italy (March 31-April 2)
Customization of Electroplating Chemistries		, , , , , , , , , , , , , , , , , , , ,
Probe technology Q&A		
Packaging of Implantable Devices		
Power devices		

(Editorial close date: 4/1)	May ∙ June	Ad Space Close Mar 13 - Materials Close Mar 22 Industry Events * indicates show distribution
Glass carriers for temporary bonding High-density and high-bandwidth C2C connections Multi-die/ substrate heterogeneous packages		SEMICON SE Asia Kuala Lumpur, Malaysia (May 7-9) ECTC Las Vegas, NV (May 28-31) IEEE/SW Test Workshop (SWTW) San Diego, CA (June 2-5) Sensors Expo
Wafer scribing/dicing Automotive Inspection for advanced packaging processes		San Jose, CA (June 25-27) • SEMICON West San Francisco, CA (July 9-11)
RF, Final test Smart devices and applications		
Bonding/debonding		

Ad Space Close May 8 - Ad Materials Close May 17